

<b>Notice of References Cited</b>	Application/Control No. 10/099,972	Applicant(s)/Patent Under Reexamination YAMAZAKI ET AL.	
	Examiner DuyVu n. Deo	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,440,865	08-2002	Lee, Szetsen Steven	438/714
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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